Dear Mr. Warren:

Enclosed is a source listing of a program which tests RAM memory in 6502 based systems. I wrote this test after using other memory test programs which did not perform a complete test. The problem areas were untested chip selects, and address line inputs. This program written in my assembler's source syntax (advertised in Vol.2 No. 8 of *DDI*), performs an exhaustive test of a user specified range of memory. The I/O is arranged for 6502 TIM based systems but can be easily changed.

The program performs two tests:

Test 1: Tests all memory cells for storage retention, and shorted data and address lines. This is done by writing:

00 11...FF 00 11...FF continually throughout the memory range for the first pass. When this has been written it is checked to validate the data. On the next pass 01 02...FF 00 01...FF is written and checked. This continues for 256 (hex FF) passes until all possible

combinations of bit patterns have been used.

Test 2: Tests the RAM chip select inputs. This is the same as test 1 except data 00 01 . . . F2 00 01 . . . F2 is used.

Before execution, enter the address of the start of the memory to be tested in 00C0 (lo) and 00C1 (hi), and the end of memory +1 in 00C2 (lo) and 00C3 (hi).

Execution begins at 0000 with the first test. If an error occurs, it will be outputted in the following

Test Pattern Address Error XXXX

When test 1 runs to completion, a break will occur and register A will contain E1 (signifying end of test 1). To execute test 2, simply continue execution (type G to TIM moni-

If errors occur, they will be of the same form as described above. When test 1 has run to completion, a break will occur and register A will contain E2 signifying the end. To continue execution at test 1, simply type G to the TIM monitor. The address range entered in 00C0-00C3 is not

altered by the memory test program.

If errors occurred in test 2 but not in test 1, you can safely assume a chip select malfunction (defective or not connected).
Usually a number of errors will occur in test 1 when the fault is a single defective address input, data input, or data output.

If a continuous sequence of addresses with errors occur, the problem is likely to be an open data input, or stuck at '1' or

"0" data output.

If every 2nd, 4th, 8th, 16th or some power of 2 address

sequence with errors occur, check for defective address inputs.

If you are checking say 2102's (1 x 1K) and are specifying a range of, say 4K of memory, and an error common to the whole range occurs, the problem is likely to be in the power leads, defective data or address buffers, stuck at '0' address inputs, stuck at '0' data inputs, or stuck at '0' data outputs.

In all of the above, you may have to examine the various memory error patterns for some similarity in order to isolate the defective component. This is especially true of the 1 x 1K 2102 memory chip where each chip is devoted to a particular data lead $(D_0 - D_7)$.

Finally, since this program has a copyright assigned, I waive this right for publication in DDJ only.

Sincerely, Carl Moser

3239 Linda Dr. Winston-Salem, NC 27106

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### 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14 ## 14
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                                                                                                                                                                                                                                                                                                                                                                                                   MCS 6582 MEMORY TEST
PROGRAM
                                                                                                                                                                                                                                                                                                         USER ENTERS MEMORY TO BE TESTED STARTING
ADDRESS IN START: AND END ADDRESS IN END.
                                                                                                                                                                                                                                                                                                                                                                                                                                                   -DE $7281 OUTPUT A PACKED RYTE (TWO DIGITS)
-DE $7374 OUTPUT TWO SPACES
-DE $7284 OUTPUT & CARRIAGE RETURN. LINE FEED
                                                                                                                                                                                                                                                                                                                                                                                                                                                   . BA $#
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LDX MAA

STY IEST-PON

LDA ME1

RRK

NOP

INC IESI-TYPI

JSR IEST-PON

LDA ME2

RRK

NOP

NOP

JND MEN-TEST

JMP MEN-TEST
                                                                                                                                                                                                                                                                                                                                                                                                                                                                                             ###
IESI+TYPE TEST 1
IESI+PGM
#E1
                                                                                     8208
8EC688
201388
49E1
02
E4
E5
C5
20198
49E2
88
E4
4C4888
    TEST 2
    8319
381E
8328
8822
8822
                                                                                     288472
4438
4288
9EC788
4C2E88
                                                                                                                                                                                                                                                                                                                                                                                                                                              JSR CRLF
LDY #38 PATTERN REGISTER
LDY #38
STX TEST+PATRN
JMP NX+PASS
                                                                                                                                                                                                                                                                                  TEST+PG4
    8828
8320
8320
8926
8937
8937
8937
8938
8938
8944
8943
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                                                                                EEC703
D391
63
ACC798
204530
98
81C4
C1C4
F303
288593
2785643
F306
286133
4C3483
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ACT ON LDDRS-TY)
ACT ON LDDRS-TY
ACT ON L
                                                                                4CC7##
2#45##
9#
C1C4
F##3
2#35##
2#61##
2#66##
D#F#
F#C/
                                                                                                                                                                                                                                                                        10002
                                                                                CR
ADCRAA
FAA6
CAF3
9A02
A20A
68
                                                                                                                                                                                                                                                                                  INC+RY
                                                                                                                                                                                                                                                                                                                                                                                                                                INY
LOA TEST-TYPE
HER EXIT
OPY #F3 RESET R(Y) TO CHECK CHIP SELECTS
ROC EXIT
LOY #F3
                                                                                                                                                                                                                                                                                                                                                                                                                                INC ADDRS
HNE SKIPHHI
INC ADDRS+$#1
LDA END
CMP ADDRS
HNE EXITE
LDA END+$#1
CMP ADDRS+$#1
FIS
                                                                                     EEC4##
D##3
EEC5##
4DC2##
CDC4##
D##6
                                                                                40C322
CDC582
48
4DC528
288172
4DC488
288172
287473
69
289172
287473
41C4
288472
68
                                                                                                                                                                                                                                                                                                                                                                                                                                PHA
LDA ADDRS+#A1
JSR TRYT OUTPUT ADDRS HE
LDA ADDRS
JSR TRYT OUTPUT ADDRS LO
JSR SPACEZ
                                                                                                                                                                                                                                                                                                                                                                                                                                                                                    LAAL ONIBRI ESSOS IN MENUSA
(WOOSE)
LAAL ONIBRI SALIESA
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$1481+$91
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CONSARN THAT H-8!

Received: 78 Jan 12

I truly enjoyed the article by ...hmmm .. let's see ... no name given, eh? Well, anyway, the article by (must be) Dr. Dobbs (or maybe Dr. Duds) himself on the great review of the Heath H8 microcomputer. Fantastic! What a swell job of reviewing. The author really got to the point. You tell 'em

The H8 HAS to be the worst 8080A microcomputer out. Mine, running with 24K at the moment, actually runs correctly when switched on! No self respecting home computer should do that. It even had the audacity to come up running immediately after I completed building it! What will all the

tinkerers do with a system that actually *runs*?

Unlike the original S-100 bus system I first built, the H8 can't destroy memory contents when a reset is performed. The damn thing keeps preserving what is in RAM. Furthermore, if you can believe it, this poor machine doesn't even let the novice write his own bootstrap program to use the cassette interface...one is already in ROM ready to use for loading or dumping. Some spoil sports these Heath people are, aren't they?

That angle rack mounting is really bad. Here, the boards are rigidly secured on top, bottom and side, making this excuse for a computer simple to transport, rather than having the fun of stuffing newspaper or packing 'pop-com' in so the boards don't snap off like some S-100 Systems. Since the mounting bracket on each board also acts as a heat sink, the fact that they are attached to the computer main frame can dissipate the heat even better, and thus, you don't have the fun of leaving the top off the computer like on other systems, nor the sheer pleasure of the fan constantly running in your ears, since none is needed.

I was able to fix the problem of not enough stuff on the boards that Doc brings up too. (After all, what fun is having a circuit board made simple, with fewer parts to go wrong, when a jumbled up board, taking three times as long to build is much more impressive looking ... even if it doesn't work.)
I just glued extra ICs on the board indiscriminately to make things more complex!

At least of Doc, the author of this H8 review, had enough sense to leave off the metal clip supplied with the H8 (to be placed by the keys mounted on the circuit board) so that his board bends as the keys are hit. I, like a fool, followed the Heath directions and put the clip on, which totally avoided the problem of the bending board Doc points out in his article. As soon as I finish this letter, I intend to immediately run up and pull the clip off my machine so I can bend my front panel board too!

Oh yes, and then there is that God awful OCTAL! My Lord, what a sin! It takes someone almost 10 minutes to get used to a new numbering system. I wish I were as lucky as Doc, and have 8 thumbs on each hand so I could use Hexadecimal too.

The fact that you can monitor, both dynamically, as well The fact that you can monitor, both dynamically, as well as statically any register, memory location or I/O port via the front panel too is also a hardship. I'd much rather have a string of LED lights to view and interpret. Or better yet, no front panel at all, like the SOL or APPLE II. Where's the challenge in seeing what you're doing?

I guess what's really horrible, as Doc points out, is the fact that there is no compatibility with existing S-100 cards. No one is going to make H8 compatible cards (excusing the already announced Godbout 12K RAM card, or some other manufacturers who have also requested to manufacture H8 compatible cards). I mean, outside of them there's only

compatible cards). I mean, outside of them, there's only Heath.

By all means, Heath has really gone too far with the H8. Swelled heads and too big for their britches, as Doc says Swelled heads and too big for their britches, as Doc says. They actually had the nerve to offer the typical hobbyist and home user a microcomputer that actually works, has a functional and useful front panel, compatible software, memory boards that hold their contents rather than dropping bits, I/O boards that operate correctly the first time they are built, solid construction and a design that isn't a rehash of all the other hardware on the market today. Damn innovaters...
next thing you know, someone may offer documentation that isn't 10 mimeographed sheets (like a lot of other systems) and give full support like the H8 documentation.

Do your readers know that the Heath people are actually

Do your readers know that the Heath people are actually giving you software in the form of Basic, console debug, text editor and assembler with the computer to get the user going faster? Where's that good old "We'll get 'em on the accessories!" rule that has become a standard in the industry? The people at Heath even returned my phone calls on some questions I had about the system; with right answers even! Now what kind of computer manufacturer is that, that actually RETURNS the users' calls, with correct answers to boot? No one else that I can think of.

And, I can see Doc's dislike of the fact that only the Heath part numbers are given on the schematics. Why make it easy

part numbers are given on the schematics. Why make it easy for the non-technician to order parts through Heath when needed? Besides, I guess Doc has the same problem I have of not knowing how to use the cross reference table in the manual (each has one), which gives the user the standard, industrial part number. Hell, you have to know how to match up numbers to use a table like that!

Finally, I have personally gained some special knowledge in writing styles. I am the author of the Microscene column in 65-Notes, a newsletter put out by the HP-65 Users Club (not affiliated with Hewlett-Packard), which is read by some 1900 members. When I ran a poor review of a micro, I was actually dumb enough to sign my name. I've learned now. This may well be my last time I'll sign any of my work that might bring

Let's hope that Heath can do better next time, in producing a piece of hardware that constantly requires revisions like the other micro manufacturers, (with their various patches and fixes). And, by all means, Mr. Warren, Jr., keep a high regard for the author of this fine review, ol Doc Duds. He's really the best.

Oh, one more thing, Mr. Warren . . . if you should find this little note of some interest, please print it in the letters column, rather than give it to "Doc Duds". At least those who subscribe to your magazine can read.

Sincerely, Mr. Craig A. Pearce

2529 S. Home Avenue Berwyn, Illinois 60402

Conclusion of "Memory Test for the 6502"

LAREL FILE: [/ = EXTERNAL]

/START=BBCB	/END=##C2	/ A D D R S = @ M C 4
/TEST+TYPE=##C6	/IESI+PAIR N=88C7	/ [BY] = 7291
/SPACE2=7374	/CRLF=7286	VEM+ TEST= 2330
TEST+PGM=##1R	NX + PATRN= 4229	NX+PASS=882E
L00P1=##34	NO+FRR1=003F	CK+PATRN=8849
L00P2=##4F	NO+FRR2=8857	INC+RY=8861
EXIT1=2060	INC+ADDRSC=RREE	SKIP+HI=8276
EX112=8884	FRROR=8885	INI+ADDRS=98A5
END+PGM=9832		
//2203		